Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/681,122	CHEN ET AL.	
Examiner	**Art Unit**	
Frank Duong	2616	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST SEARCH (see printout)	5/15/2007	FD
INVENTORSHIP SEARCH (see printout)	5/14/2007	FD
IEEE/INTERNET SEARCH	5/14/2007	FD